

<b>Notice of References Cited</b>	Application/Control No. 10/599,862		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner NICHOLAS LEE		Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0013077 a1	01-2004	Saito et al.	369/112.24
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*	C	US-5,272,482	12-1993	Hannah et al.	342/176
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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